

<b>Notice of References Cited</b>	Application/Control No. 10/708,879	Applicant(s)/Patent Under Reexamination WEI ET AL.	
	Examiner Robert J. Popovics	Art Unit 1724	Page 1 of 3

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<b>Notice of References Cited</b>	Application/Control No. 10/708,879	Applicant(s)/Patent Under Reexamination WEI ET AL.	
	Examiner Robert J. Popovics	Art Unit 1724	Page 2 of 3

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	Examiner Robert J. Popovics		Art Unit 1724	Page 3 of 3

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